

RAA210040

5V, 4A Step-Down DC/DC Mini Module with Integrated Inductor

The **RAA210040** power module is a compact, synchronous step-down, non-isolated complete power supply, capable of delivering up to 4A of continuous current. By operating from a single 2.7V to 5.5V input power rail and integrating the controller, gate driver, power inductor, and MOSFETs, the RAA210040 is optimized for space-constrained applications.

Based on a peak current mode control scheme, the RAA210040 provides fast transient response and excellent loop stability. The output voltage can be set as low as 0.6V, with setpoint accuracy better than 1.5% over line, load, and temperature. The operating frequency has a 2MHz default setting; however, it can also be set from 500kHz to 4MHz by an external resistor. The external synchronization is supported with an external clock signal up to 4MHz. The RAA210040 supports a 100% duty cycle operation to minimize the switching losses and allows less than 200mV dropout voltage. A dedicated enable pin and power-good flag allows for easy system power rails sequencing.

An array of protection features, including input Undervoltage Lockout (UVLO), Overcurrent Protection (OCP), output Overvoltage Protection (OVP), and Over-temperature Protection (OTP), ensures safe operations under abnormal operating conditions.

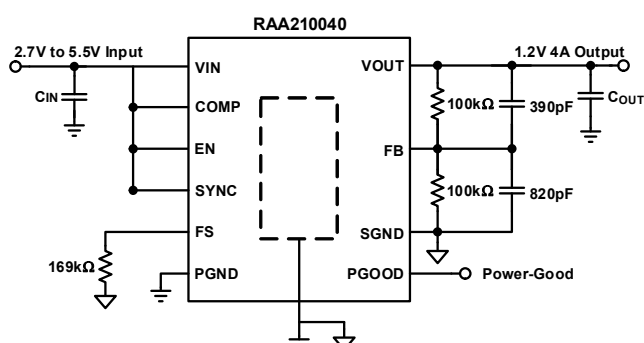


Figure 1. Typical Application Circuit

Features

- 4A complete power supply
 - Integrates controller, gate driver, MOSFETs, and inductor
- 2.7V to 5.5V input voltage range
- Adjustable output voltage
 - As low as 0.6V with $\pm 1.5\%$ accuracy over line, load, and temperature
 - Up to 95% efficiency
- Default 2MHz current mode control operation
 - 500kHz to 4MHz resistor adjustable
 - External synchronization up to 4MHz
 - 100% duty cycle
- Dedicated enable pin and power-good flag
- Internal 1ms soft start-up time
- Soft-stop output discharge
- UVLO, OCP, negative OCP, OVP, and OTP
 - OCP/Short-Circuit Protection (SCP) hiccup mode
- Compact RoHS compliant 3mmx3mmx1.7mm 10 lead dual flat embedded laminate package

Applications

- Telecom, Industrial, optical, and medical equipment
- Point-of-load conversions
- MCU, MPU, DSP, and FPGA

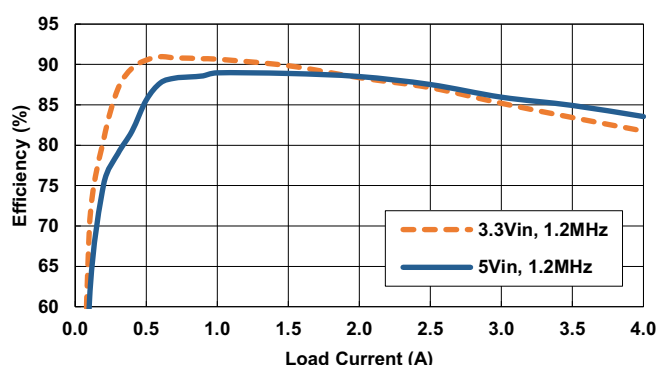


Figure 2. Efficiency $V_{OUT} = 1.2V$

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1. Overview

1.1 Typical Application Circuits

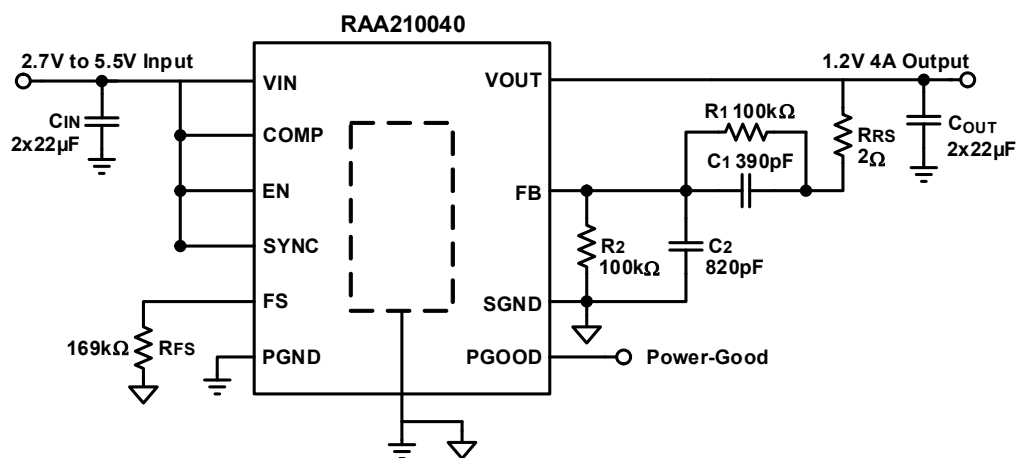


Figure 3. $V_{OUT} = 1.2V$, $f_{SW} = 1.2MHz$, PWM Mode, $t_{SS} = 1ms$

1.2 Block Diagram

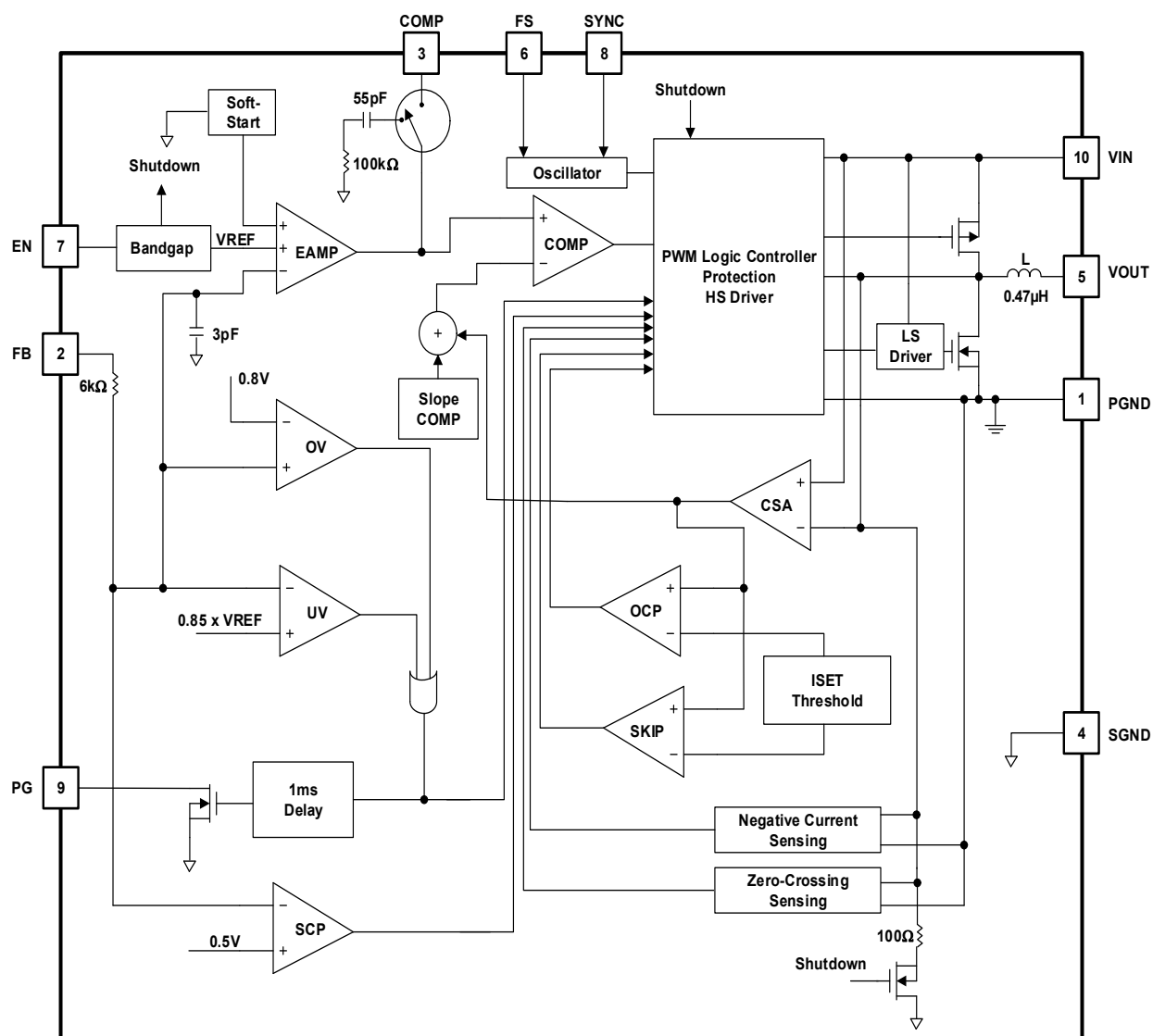
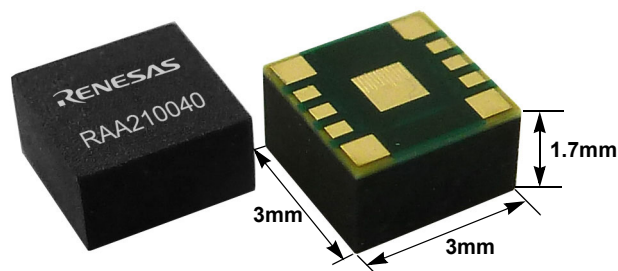
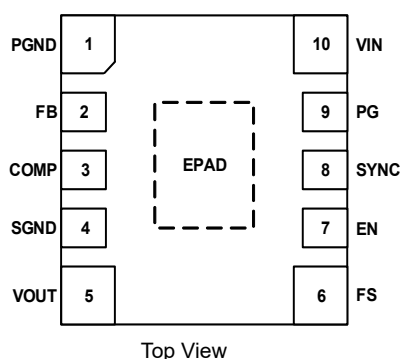


Figure 4. Block Diagram

2. Pin Information

2.1 Pin Assignments



2.2 Pin Descriptions

Pin Number	Pin Name	Function
1	PGND	Power ground. Connect it close to the (-) terminals of the external input capacitors and output capacitors.
2	FB	Voltage setting pin. The module output voltage is set by an external resistor divider connected to FB. With a properly selected divider, the output voltage is set to any voltage between 0.6V and 5V. Renesas also recommends placing a ceramic capacitor in parallel to ensure system stability at extreme operating conditions. Table 1 lists the resistor and capacitor values for various typical output voltages.
3	COMP	Compensation pin. COMP is the output of the transconductance error amplifier. For most applications, directly connect COMP to VIN to select internal compensation to stabilize the system and achieve an optimal transient response. For applications where external compensation is required, connect COMP to SGND with an external compensation network.
4	SGND	Signal ground. Must connect it to EPAD for proper electrical performance. See Layout Guidelines for more information.
5	VOUT	Power output of the module. Place the output capacitors as close as possible to the module output. See Layout Guidelines for more information.
6	FS	Frequency selection pin. This pin sets the module switching frequency by connecting a resistor to SGND. The frequency of operation can be programmed between 500kHz to 4MHz. The default frequency is 2MHz if FS is connected to VIN.
7	EN	Module enable pin. Enable the module by driving EN high. Shuts down the module and discharge the output capacitor when driven low. Typically tied to VIN directly. Note: Do not leave this pin floating.
8	SYNC	Synchronization pin. Connect to logic high or the input voltage (VIN) for PWM mode. Drive with a 500kHz to 4MHz square wave for external synchronization. Note: Do not leave this pin floating.
9	PG	Power-good pin. Power-good is an open-drain output. Use a 10kΩ to 100kΩ pull-up resistor connected between VIN and PG. During power-up or EN start-up, the PG rising edge is delayed by 1ms after the output is in regulation.
10	VIN	Power input of the module. Tie directly to the input rail between 2.7V~5.5V. Note: You must place minimum total 2x22μF X7R input ceramic capacitors as close as possible to the module input. Add additional capacitance if possible. See Layout Guidelines for more information.
-	EPAD	Power ground. Must connect it to SGND for proper electrical performance. Place as many vias as possible under the EPAD for optimal thermal performance.

Table 1. RAA210040 Design Guide Matrix (See Figure 3)

Case	V _{IN} (V)	V _{OUT} (V)	R ₁ (kΩ)	R ₂ (kΩ)	C _{IN} (Ceramic) (μF)	C _{OUT} (Ceramic) (μF)	Freq (MHz)	R _{FS} (kΩ)	C ₁ (pF)	C ₂ (pF)
1	3.3	0.6	100	open	2x22	1x47	0.8	261	390	820
2	3.3	0.8	100	301	2x22	2x22	0.9	232	390	820
3	3.3	0.9	100	200	2x22	2x22	1	205	390	820
4	3.3	1	100	150	2x22	2x22	1	205	390	820
5	3.3	1.2	100	100	2x22	2x22	1.2	169	390	820
6	3.3	1.5	100	66.5	2x22	2x22	1.3	154	390	680
7	3.3	1.8	100	49.9	2x22	2x22	1.5	133	390	560
8	3.3	2.5	100	31.6	2x22	2x22	1.8	107	390	470
9	5	1	100	150	2x22	2x22	1	205	390	820
10	5	1.2	100	100	2x22	2x22	1.2	169	390	820
11	5	1.5	100	66.5	2x22	2x22	1.3	154	390	680
12	5	1.8	100	49.9	2x22	2x22	1.5	133	390	560
13	5	2.5	100	31.6	2x22	2x22	1.8	107	390	470
14	5	3.3	100	22.1	2x22	2x22	2.4	76.8	390	470

Table 2. Recommended Input/Output Capacitor

Vendor	Value	Part Number
Murata, Input Ceramic	22μF, 10V, 1206, X7R	GRM31CR71A226KE15L
Murata, Output Ceramic	22uF, 6.3V, 1206, X7R	GRM31CR70J226KE19L
Murata, Output Ceramic	47μF, 6.3V, 1206, X7R	GRM32ER70J476ME20L

3. Specifications

3.1 Absolute Maximum Ratings

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

Parameter	Minimum	Maximum	Unit
VIN to PGND	-0.3	+5.8 (DC) or +7V (20ms)	V
EN, FS, PG, FB, SYNC, COMP to SGND	-0.3	$V_{IN} + 0.3$	V
VOU to PGND	-0.3	$V_{IN} + 0.3$	V
Maximum Storage Temperature Range	-65	+150	°C
Human Body Model (Tested per JS-001-2014)	-	2.0	kV
Charged Device Model (Tested per JS-002-2014)	-	750	V
Latch-Up (Tested per JESD78E; Class II, Level A, +125°C)	-	100	mA

3.2 Thermal Information

Parameter	Package	Symbol	Conditions	Typical Value	Unit
Thermal Resistance	10 Lead Dual Flat Embedded Laminate Package	$\theta_{JA}^{[1]}$	Junction to air	33.84	°C/W
		$\theta_{JC}^{[2]}$	Junction to case	16.4	°C/W

- θ_{JA} is measured in free air with the module mounted on a 4-layer thermal test board 3x4.5 inch in size with significant coverage of 2oz Cu on both top and bottom layers, and 1oz Cu on internal layers, with numerous vias.
- For θ_{JC} , the case temperature location is the center of the exposed metal pad on the package underside.

3.3 Recommended Operating Conditions

Parameter	Minimum	Maximum	Unit
VIN to GND	2.7	5.5	V
Output Voltage, V_{OUT}	0.6	5	V
Output Current, I_{OUT}	0	4	A
Junction Temperature Range, T_J	-40	+125	°C

3.4 Electrical Specifications

Unless otherwise noted, all parameter limits are established across the recommended operating conditions and the specification limits are measured at the following conditions: $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{IN} = 3.6\text{V}$, $V_{OUT} = 1.2\text{V}$, unless otherwise noted. Typical specifications are measured at $T_A = +25^\circ\text{C}$. **Boldface limits apply across the internal junction temperature range, -40°C to $+125^\circ\text{C}$.**

Parameter	Symbol	Test Conditions	Min ^[1]	Typ	Max ^[1]	Unit
Module Input Supply						
Input Voltage Range	V_{IN}		2.7		5.5	V

Unless otherwise noted, all parameter limits are established across the recommended operating conditions and the specification limits are measured at the following conditions: $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{IN} = 3.6\text{V}$, $V_{OUT} = 1.2\text{V}$, unless otherwise noted. Typical specifications are measured at $T_A = +25^{\circ}\text{C}$. **Boldface limits apply across the internal junction temperature range, -40°C to $+125^{\circ}\text{C}$.** (Cont.)

Parameter	Symbol	Test Conditions	Min ^[1]	Typ	Max ^[1]	Unit
V_{IN} Undervoltage Lockout Threshold	V_{UVLO}	Rising, no load		2.5	2.7	V
		Falling, no load	2.2	2.45		V
Quiescent Supply Current	I_{VIN}	SYNC = $V_{IN} = 3.6\text{V}$, $f_{SW} = 2\text{MHz}$, EN = high, $I_{OUT} = 0\text{A}$		19	25	mA
		SYNC = $V_{IN} = 5\text{V}$, $f_{SW} = 2\text{MHz}$, EN = high, $I_{OUT} = 0\text{A}$		23	30	mA
Shutdown Supply Current	I_{SD}	SYNC = $V_{IN} = 5.5\text{V}$, EN = low		4.5	10	uA
Output Regulation						
Output Continuous Current Range ^[2]	I_{OUT}		0		4	A
Output Voltage Range ^[2]	V_{OUT_RANGE}		0.6		5	V
Output Voltage Accuracy ^[2]	V_{OUT_ACCY}	Total variation with line, load, and temperature ($-40^{\circ}\text{C} \leq T_J \leq +125^{\circ}\text{C}$)	-1.5		1.5	%
Line Regulation ^[2]	$\Delta V_{OUT}/V_{OUT_SET}$	V_{IN} from 2.7V to 5.5V, $I_{OUT} = 0\text{A}$	-1		1	%
Load Regulation ^[2]	$\Delta V_{OUT}/V_{OUT_SET}$	From 0A to 4A, $V_{IN} = 5\text{V}$	-1		1	%
Output Ripple Voltage	$V_{OUT(AC)}$	$V_{IN} = 5\text{V}$, $V_{OUT} = 1.2\text{V}$, $I_{OUT} = 4\text{A}$, $f_{SW} = 1.2\text{MHz}$, 2x22μF ceramic capacitor		8		mV _{P-P}
Dynamic Characteristics						
Voltage Change of Positive Load Step	V_{OUT_DP}	Current slew rate = 2.5A/μs, $V_{IN} = 5\text{V}$, 2x22μF ceramic capacitor $V_{OUT} = 1.2\text{V}$, $I_{OUT} = 0\text{A}$ to 4A		60		mV
Voltage Change of Negative Load Step	V_{OUT_DN}	Current slew rate = 2.5A/μs, $V_{IN} = 5\text{V}$, 2x22μF ceramic capacitor $V_{OUT} = 1.2\text{V}$, $I_{OUT} = 4\text{A}$ to 0A		60		mV
Current Protection						
Current Limit Blanking Time	t_{OCON}			17		clock pulses
Hiccup Time	t_{hiccup}			8		ms
Positive Peak Current Limit	I_{PLIMIT}		5.2	6.6	9	A
Negative Current Limit	I_{NLIMIT}		-6	-3	-0.6	A
EN Threshold						
Logic Input Low					0.4	V
Logic Input High			0.9			V
EN Logic Input Leakage Current		Pulled up to 3.6V		0.1	1	uA
Default Internal Soft-Starting						
Default Internal Output Ramping Time	t_{SS}	SS = SGND		1		ms

Unless otherwise noted, all parameter limits are established across the recommended operating conditions and the specification limits are measured at the following conditions: $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{IN} = 3.6\text{V}$, $V_{OUT} = 1.2\text{V}$, unless otherwise noted. Typical specifications are measured at $T_A = +25^{\circ}\text{C}$. **Boldface limits apply across the internal junction temperature range, -40°C to $+125^{\circ}\text{C}$.** (Cont.)

Parameter	Symbol	Test Conditions	Min ^[1]	Typ	Max ^[1]	Unit
Power-Good						
Output Low Voltage		I _{PG} = 1mA			0.3	V
PG Delay Time (Rising Edge)	t _{PGR}	Time from V _{OUT} reached regulation	0.5	1	2	ms
PG Delay Time (Falling Edge)	t _{PGF}			6.5		us
PG Leakage Current	I _{PGLKG}	PG = 3.6V		10	100	nA
OVP PG Rising Threshold	V _{PGR_OVP}			0.8		V
UVP PG Rising Threshold	V _{PGR_UVP}		80	86	90	%
UVP PG Hysteresis				5.4		%
Reference Section						
Internal Reference Voltage	V _{REF}		0.593	0.60 0	0.606	V
FB Bias Current	I _{FBLKG}	FB = 0.75V		0.1		uA
Compensation						
Error Amplifier Transconductance		Internal Compensation		126		uA/V
		External Compensation		132		uA/V
Current Sense Gain			0.145	0.2	0.25	Ω
PWM Regulator						
Maximum Duty Cycle	d _{MAX}			100		%
Minimum On-Time	t _{ON_MIN}	SYNC=high			100	ns
Oscillator						
Switching Frequency	f _{SW}	f _{SW} =2MHz	1.7	2	2.35	MHz
Switching Frequency		R _{FS} = 402kΩ	0.475	0.5	0.525	MHz
Switching Frequency		R _{FS} = 42.2kΩ	3.94	4	4.125	MHz
Synchronization						
SYNC Synchronization Range	f _{SYNC}		0.5		4	MHz
SYNC Logic Low-to-High Transition Range			0.67	0.76	0.84	V
SYNC Hysteresis				0.17		V
SYNC Logic Input Leakage Current		V _{IN} = 3.6V		4	5	uA
Over-Temperature						
Over-Temperature Shutdown	T _{OT-TH}			150		°C
Over-Temperature Hysteresis	T _{OT-HYS}			25		°C

1. Compliance to datasheet limit is assured by one or more methods: production test, characterization and/or design.
2. Compliance to limits is assured by characterization and design.

4. Typical Performance Graphs

4.1 Efficiency Performance

Operating condition: $T_A = +25^\circ\text{C}$, no air flow, PWM mode. Typical values are used unless otherwise noted.

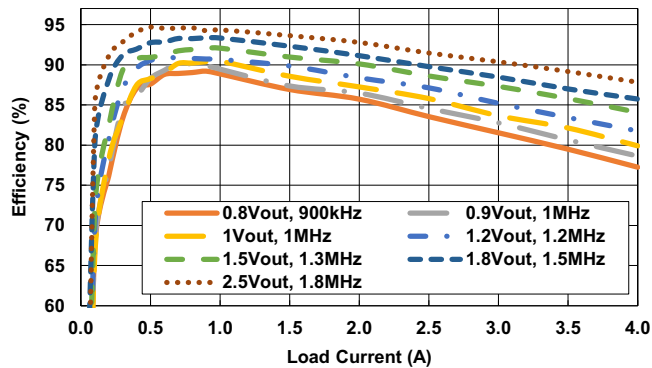


Figure 5. $V_{IN} = 3.3\text{V}$

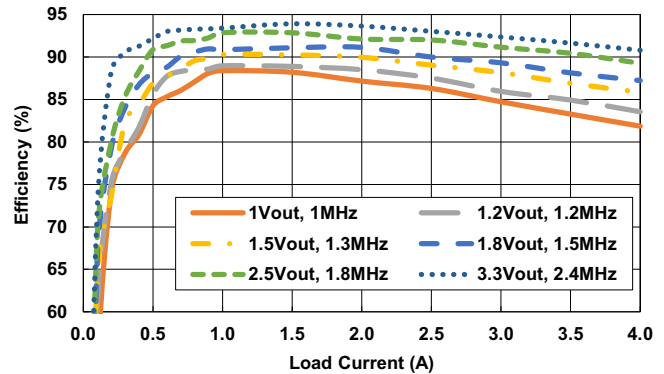


Figure 6. $V_{IN} = 5\text{V}$

4.2 Output Voltage Ripple

Operating condition: $T_A = +25^\circ\text{C}$, no air flow, PWM mode. Typical values are used unless otherwise noted.

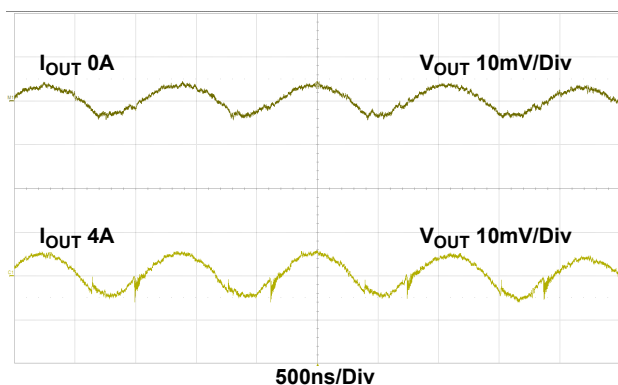


Figure 7. Output Ripple, $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.8\text{V}$, $f_{SW} = 900\text{kHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

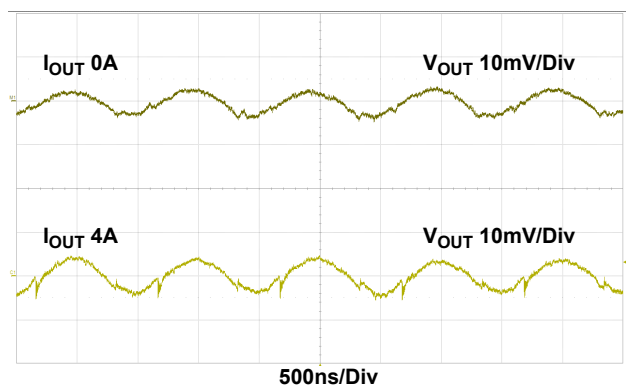


Figure 8. Output Ripple, $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.9\text{V}$, $f_{SW} = 1\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

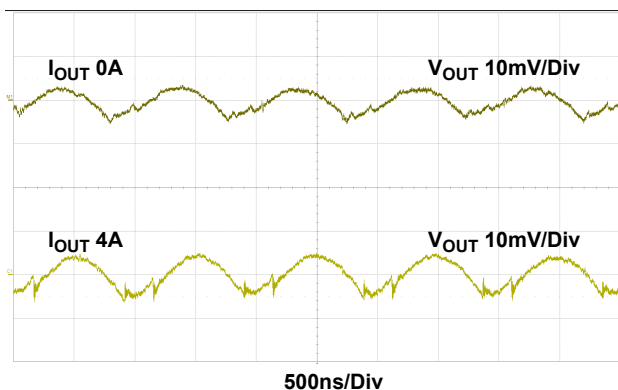


Figure 9. Output Ripple, $V_{IN} = 5\text{V}$, $V_{OUT} = 1\text{V}$, $f_{SW} = 1\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

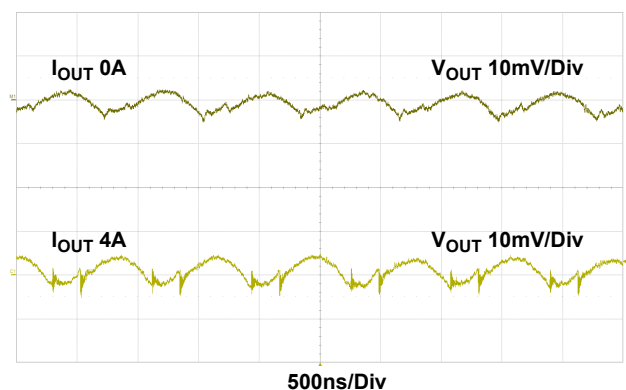


Figure 10. Output Ripple, $V_{IN} = 5\text{V}$, $V_{OUT} = 1.2\text{V}$, $f_{SW} = 1.2\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

Operating condition: $T_A = +25^\circ\text{C}$, no air flow, PWM mode. Typical values are used unless otherwise noted. (Cont.)

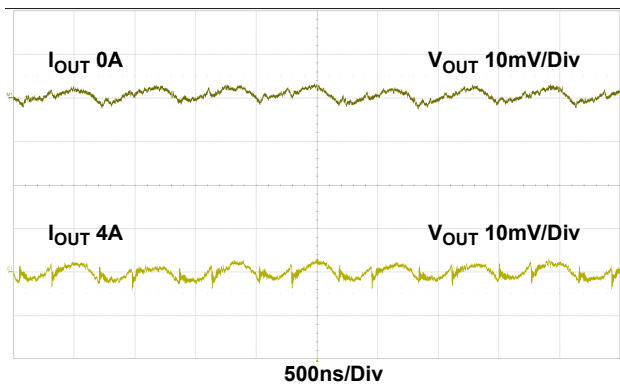


Figure 11. Output Ripple, $V_{IN} = 5\text{V}$, $V_{OUT} = 1.8\text{V}$, $f_{SW} = 1.5\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

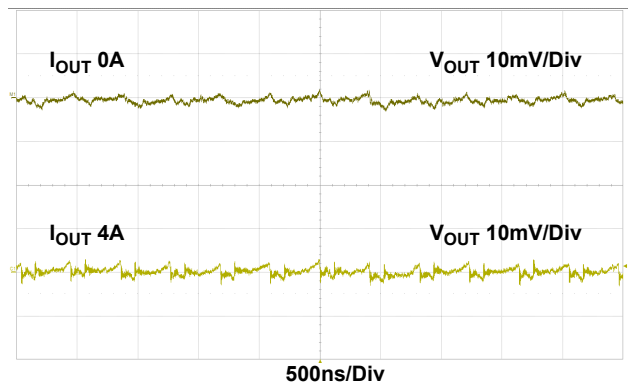


Figure 12. Output Ripple, $V_{IN} = 5\text{V}$, $V_{OUT} = 3.3\text{V}$, $f_{SW} = 2.4\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

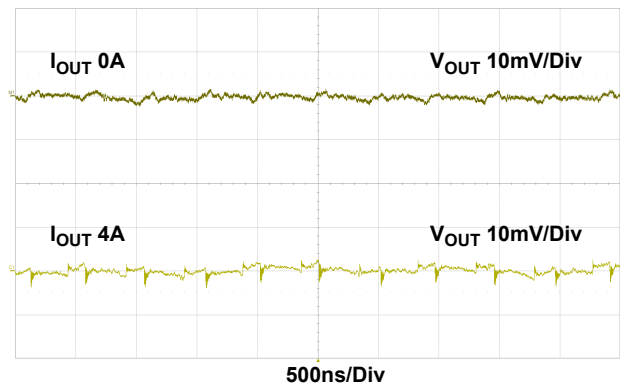


Figure 13. Output Ripple, $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.8\text{V}$, $f_{SW} = 2\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

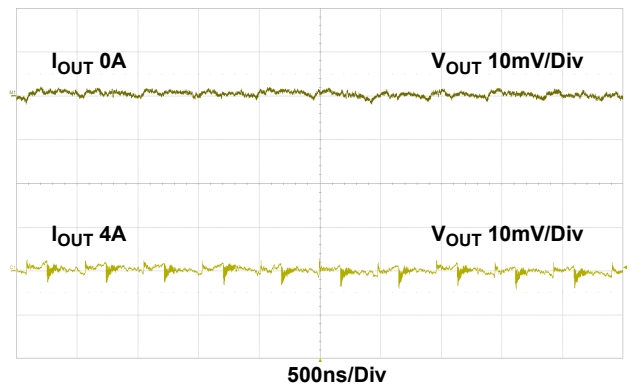


Figure 14. Output Ripple, $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.9\text{V}$, $f_{SW} = 2\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

4.3 Load Transient Response Performance

Operating condition: $T_A = +25^\circ\text{C}$, no air flow, PWM mode, 0.4A - 3.6A, 2.5A/µs step load. Typical values are used unless otherwise noted.

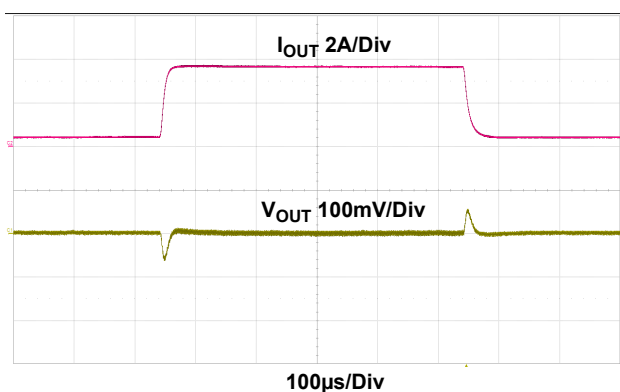


Figure 15. $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.8\text{V}$, $f_{SW} = 900\text{kHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

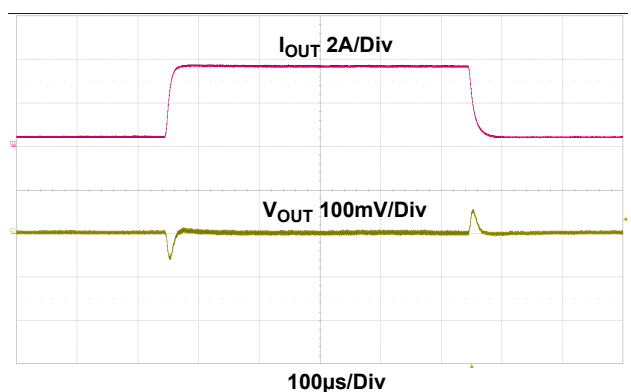


Figure 16. $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.9\text{V}$, $f_{SW} = 1\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

Operating condition: $T_A = +25^\circ\text{C}$, no air flow, PWM mode, 0.4A - 3.6A, 2.5A/ μs step load. Typical values are used unless otherwise noted. (Cont.)

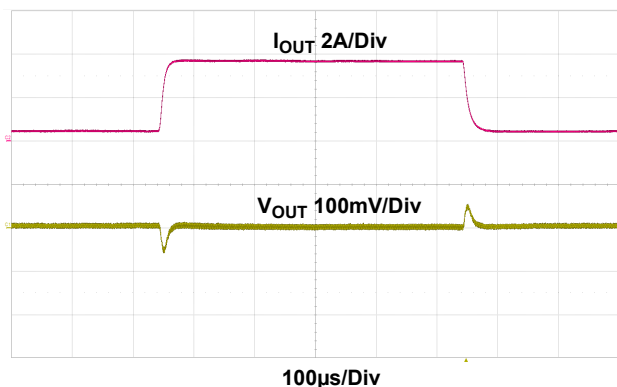


Figure 17. $V_{IN} = 5\text{V}$, $V_{OUT} = 1\text{V}$, $f_{SW} = 1\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

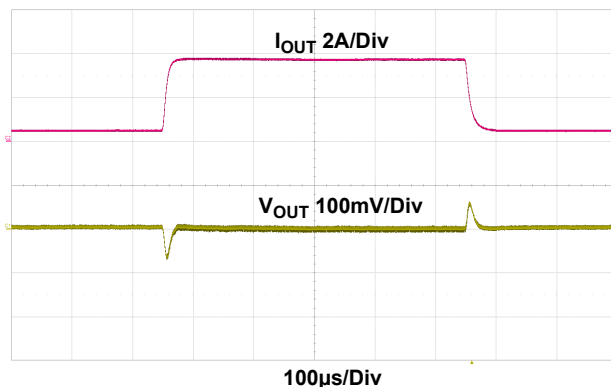


Figure 18. $V_{IN} = 5\text{V}$, $V_{OUT} = 1.2\text{V}$, $f_{SW} = 1.2\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

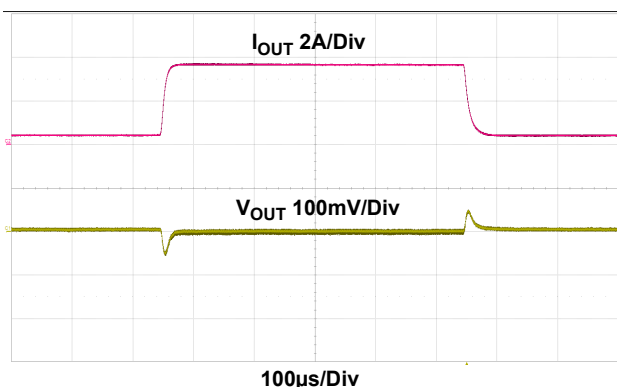


Figure 19. $V_{IN} = 5\text{V}$, $V_{OUT} = 1.8\text{V}$, $f_{SW} = 1.5\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

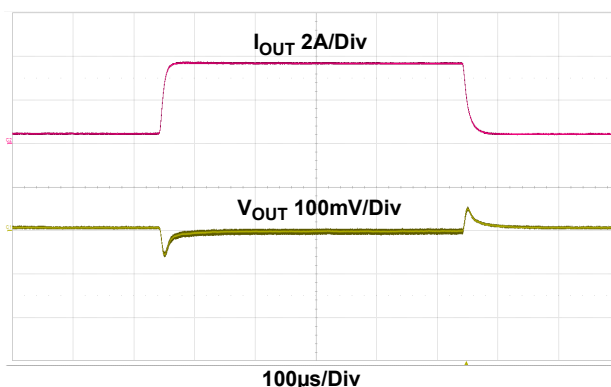


Figure 20. $V_{IN} = 5\text{V}$, $V_{OUT} = 3.3\text{V}$, $f_{SW} = 2.4\text{MHz}$, $C_{OUT} = 2 \times 22\mu\text{F}$ Ceramic

4.4 Start-Up Waveforms

Operating condition: $T_A = +25^\circ\text{C}$, no air flow. Typical values are used unless otherwise noted.

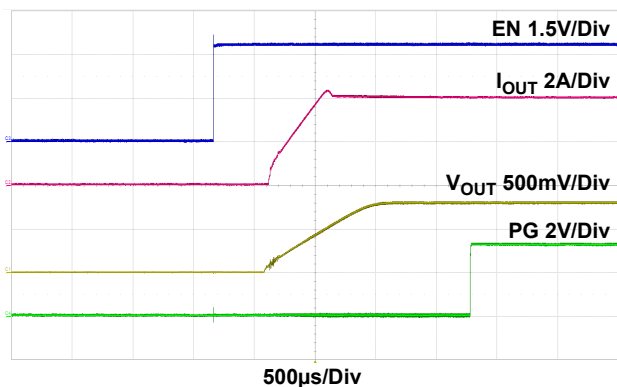


Figure 21. Start-Up Waveforms; $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.8\text{V}$, $I_{OUT} = 4\text{A}$

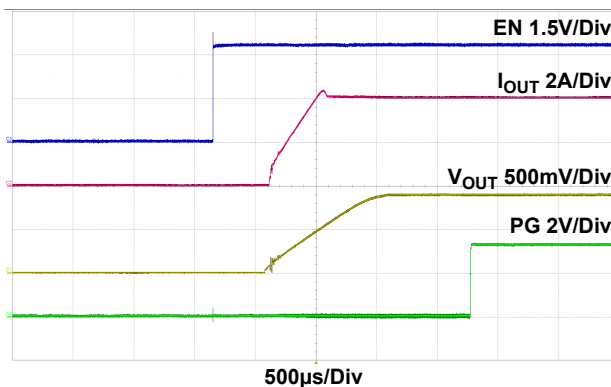


Figure 22. Start-Up Waveforms; $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.9\text{V}$, $I_{OUT} = 4\text{A}$

Operating condition: $T_A = +25^\circ\text{C}$, no air flow. Typical values are used unless otherwise noted. (Cont.)

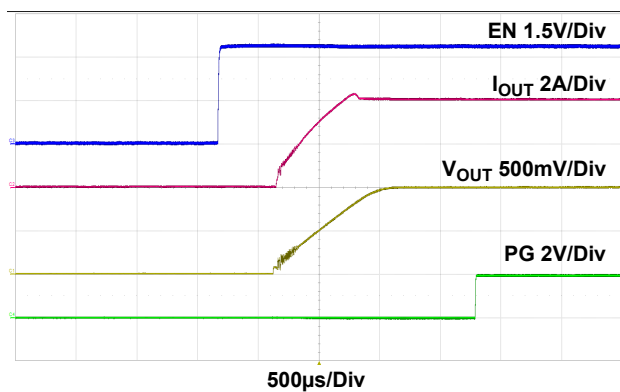


Figure 23. Start-Up Waveforms; $V_{IN} = 5\text{V}$, $V_{OUT} = 1\text{V}$, $I_{OUT} = 4\text{A}$

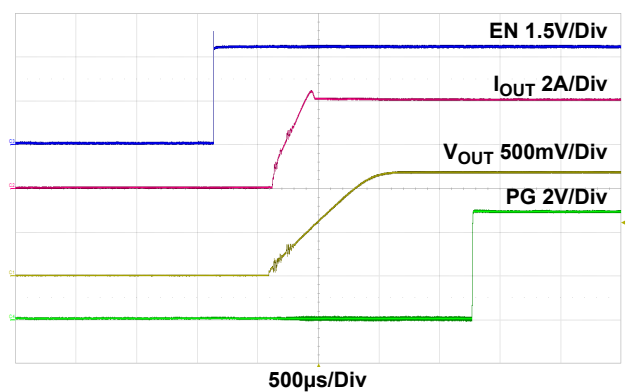


Figure 24. Start-Up Waveforms; $V_{IN} = 5\text{V}$, $V_{OUT} = 1.2\text{V}$, $I_{OUT} = 4\text{A}$

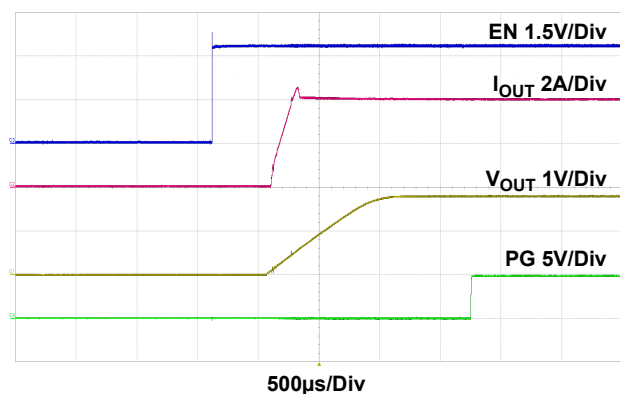


Figure 25. Start-Up Waveforms; $V_{IN} = 5\text{V}$, $V_{OUT} = 1.8\text{V}$, $I_{OUT} = 4\text{A}$

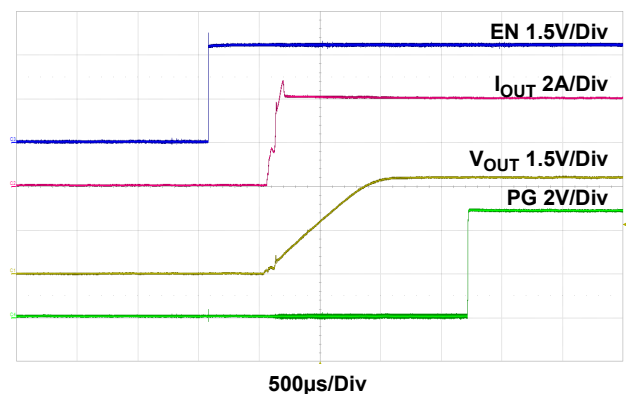


Figure 26. Start-Up Waveforms; $V_{IN} = 5\text{V}$, $V_{OUT} = 3.3\text{V}$, $I_{OUT} = 4\text{A}$

4.5 Derating

PWM operation. All of the following curves were plotted at $T_J = +120^\circ\text{C}$. For the test conditions, see Table 1.

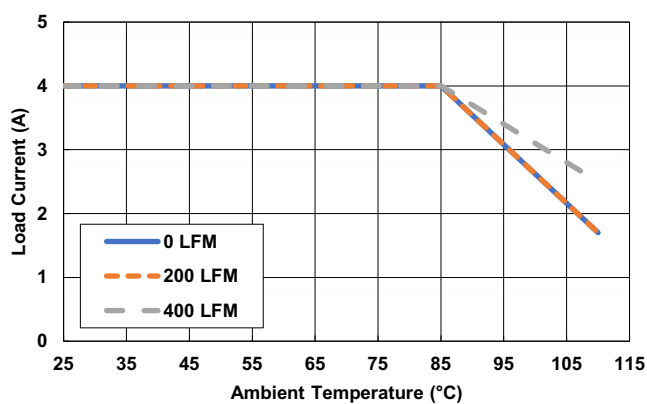


Figure 27. $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.8\text{V}$, $f_{SW} = 900\text{kHz}$

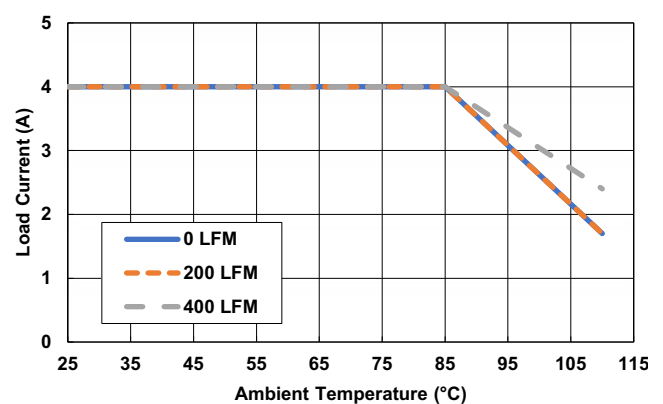


Figure 28. $V_{IN} = 3.3\text{V}$, $V_{OUT} = 0.9\text{V}$, $f_{SW} = 1\text{MHz}$

PWM operation. All of the following curves were plotted at $T_J = +120^\circ\text{C}$. For the test conditions, see Table 1. (Cont.)

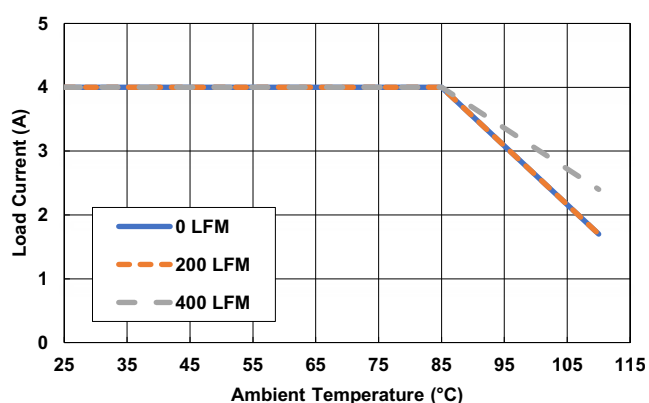


Figure 29. $V_{IN} = 5\text{V}$, $V_{OUT} = 1\text{V}$, $f_{SW} = 1\text{MHz}$

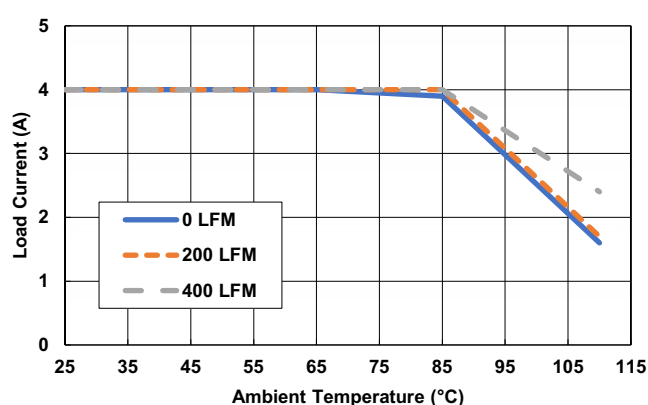


Figure 30. $V_{IN} = 5\text{V}$, $V_{OUT} = 1.2\text{V}$, $f_{SW} = 1.2\text{MHz}$

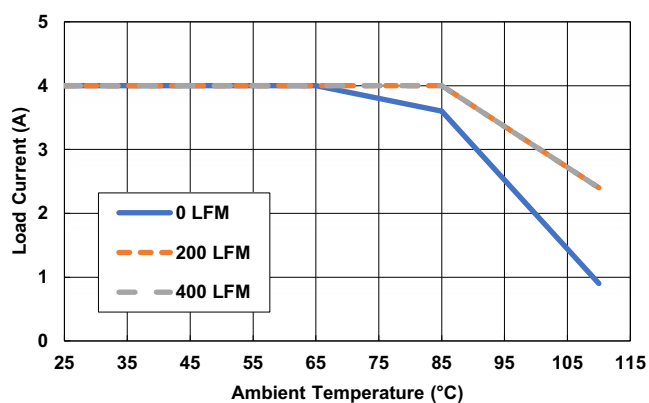


Figure 31. $V_{IN} = 5\text{V}$, $V_{OUT} = 1.8\text{V}$, $f_{SW} = 1.5\text{MHz}$

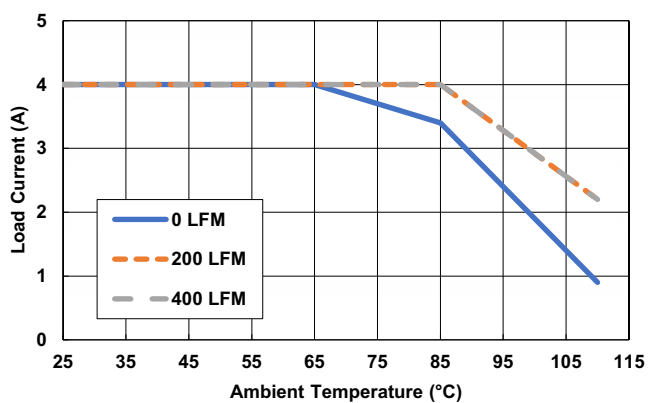


Figure 32. $V_{IN} = 5\text{V}$, $V_{OUT} = 2.5\text{V}$, $f_{SW} = 1.8\text{MHz}$

5. Functional Description

The RAA210040 is a compact 4A step-down high-efficiency power module optimized for space-constrained applications. The module switches at 2MHz by default when the FS pin is shorted to VIN. The switching frequency is also adjustable from 500kHz to 4MHz through a resistor, R_{FS} , from FS to SGND. Peak current mode control scheme is implemented for a fast transient response. By shorting the COMP pin to VIN, the module uses internal compensation to stabilize the system and optimize transient response. Other features include soft-stop output discharge, external synchronization, 100% duty cycle operation, and low quiescent current. The supply current is typically only 4.5μA when the module is shut down.

5.1 PWM Control Scheme

The RAA210040 employs peak current-mode Pulse-Width Modulation (PWM) for fast transient response and pulse-by-pulse current limiting. Pulling the SYNC pin high (>0.8V) forces the module into PWM mode. As shown in Figure 4, the current loop consists of the oscillator, PWM comparator, a current-sensing circuit, and slope compensation for the current loop stability. The slope compensation is 440mV/Ts, which changes with frequency. The gain for the current-sensing circuit is typically 200mV/A. The control reference for the current loops comes from the output of the Error Amplifier (EAMP).

The PWM operation is initialized by the clock from the oscillator. The P-channel MOSFET is turned on at the beginning of a PWM cycle and the current in the MOSFET starts to ramp up. When the sum of the Current-Sense Amplifier (CSA) and the slope compensation reaches the control reference of the current loop, the PWM comparator COMP sends a signal to the PWM logic to turn off the P-channel MOSFET and turn on the N-channel MOSFET. The N-channel MOSFET stays on until the end of the PWM cycle. Figure 33 shows the typical operating waveforms during the PWM operation. The dotted lines illustrate the sum of the slope compensation ramp and the output of the CSA.

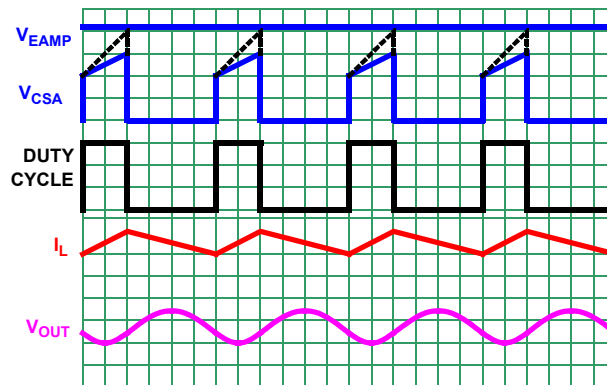


Figure 33. PWM Operation Waveforms

The output voltage is regulated by controlling the V_{EAMP} voltage to the current loop. The bandgap circuit outputs a 0.6V reference voltage to the voltage loop. The feedback signal comes from the FB pin. The soft start-up block only affects the operation during start-up and is discussed separately, see [Soft Start-Up](#). The error amplifier is a transconductance amplifier that converts the voltage error signal to a current output. When the COMP is tied to VIN, the voltage loop is internally compensated with the 55pF and 100kΩ RC network.

5.2 Frequency Adjustment

The switching frequency of RAA210040 is adjustable ranging from 500kHz to 4MHz using a simple resistor R_{FS} across FS to SGND. The switching frequency setting is based on Equation 1:

$$(EQ. 1) \quad R_{FS}[k\Omega] = \frac{220 \cdot 10^3}{f_{OSC}[kHz]} - 14$$

When the FS pin is directly tied to VIN, the frequency of operation is fixed at 2MHz. See [Table 1](#) to help with the selection of switching frequency for typical operation conditions. More detailed information on recommended switching frequency is provided in the [Switching Frequency Selection](#) section.

5.3 Overcurrent Protection (OCP)

The overcurrent protection is implemented by monitoring the CSA output with the OCP comparator, as shown in [Figure 4](#). The current-sensing circuit has a gain of 200mV/A, from the P-channel MOSFET current to the CSA output. When the CSA output reaches the threshold, the OCP comparator is tripped and turns off the P-channel MOSFET immediately. The overcurrent function protects the module from a shorted output by monitoring the current flowing through the P-channel MOSFET.

With the detection of an overcurrent condition, the P-channel MOSFET is immediately turned off and is not turned on again until the next switching cycle. With the detection of the initial overcurrent condition, the overcurrent fault counter is set to 1. During the subsequent cycle, if another overcurrent condition is detected, the OC fault counter is incremented. If there are 17 sequential OC fault detections, the module shuts down under an overcurrent fault condition. An overcurrent fault condition results in the module attempting to restart in Hiccup mode within the delay of eight soft start-up periods. At the end of the eighth soft start-up wait period, the fault counters are reset and soft start-up is attempted again. If the overcurrent condition goes away during the delay of eight soft start-up periods, the output resumes back into regulation after the Hiccup mode expires as shown in [Figure 34](#).

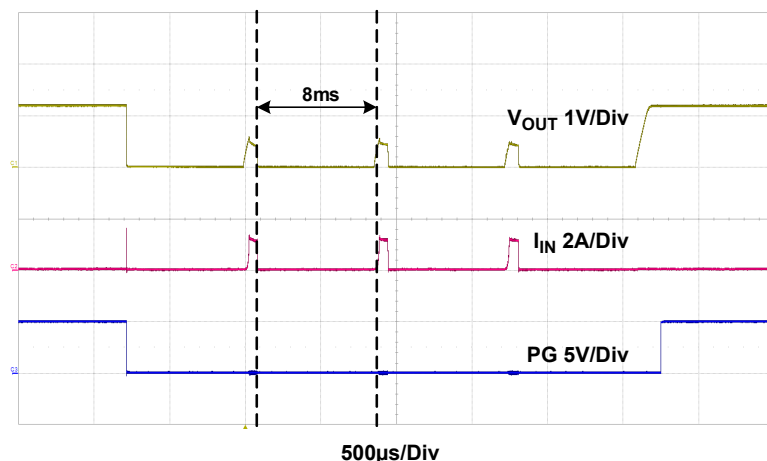


Figure 34. OCP Response; Output Short-Circuited from No Load to Ground and Released, $V_{OUT} = 1.2V$

5.4 Negative Current Protection

Similar to overcurrent, the negative current protection is realized by monitoring the current across the low-side N-channel MOSFET, as shown in [Figure 4](#). When the valley point of the inductor current reaches -3A for four consecutive cycles, both P-channel MOSFET and N-channel MOSFET are turned off. The 100Ω in parallel to the N-channel MOSFET activates discharging the output into regulation. The control begins to switch when output is within regulation.

5.5 Power-Good

Power-Good (PG) is the open-drain output of a window comparator that continuously monitors the module output voltage. PG is actively held low when EN is low and during the module soft start-up period. After the 1ms delay of the soft start-up period, PG becomes high impedance as long as the output voltage is within the nominal regulation voltage set by V_{FB} . During an output overvoltage fault condition (output voltage is 33% higher than nominal value) or an output undervoltage fault condition (output voltage is 15% lower than nominal value), PG is pulled low. Any fault condition forces PG low until the fault condition is cleared during soft start-up. For logic level output voltages, connect an external pull-up resistor between PG and VIN. A 100kΩ resistor works well in most applications.

5.6 Undervoltage Lockout (UVLO)

When the input voltage is below the Undervoltage Lockout (UVLO) threshold, the module is disabled.

5.7 Soft Start-Up

The soft start-up reduces the inrush current during soft start-up. The soft-start block outputs a ramp reference to the input of the error amplifier. This voltage ramp limits the inductor current and the output voltage rise time so that the output voltage rises in a controlled fashion. When VFB is less than 0.1V at the beginning of the soft start-up, the switching frequency is reduced to 200kHz, so that the output can start-up smoothly at light load conditions. The RAA210040 supports pre-biased output condition during soft start-up. The default soft start-up period is approximately 1ms.

5.8 External Synchronization Control

The operating frequency can be synchronized up to 4MHz by an external signal applied to the SYNC pin. The rising edge of the SYNC signal triggers the rising edge of the PWM ON pulse. To ensure proper operation, Renesas recommends using an external SYNC frequency within $\pm 25\%$ of the switching frequency set by the FS pin.

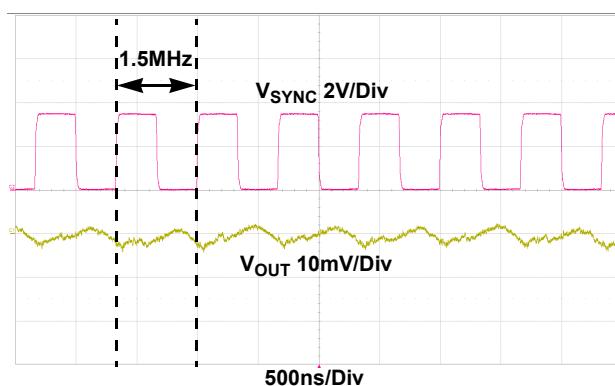


Figure 35. External Frequency Synchronization Waveform, $V_{IN} = 5V$, $V_{OUT} = 1.2V$, $f_{SYNC} = 1.5MHz$, $I_{OUT} = 0A$

5.9 Enable

The enable (EN) input allows you to control the turning on or off of the module for purposes such as power-up sequencing. When the module is enabled, there is typically a 600 μ s delay for waking up the bandgap reference, and then the soft start-up begins. EN should be held below the logic input low until V_{IN} exceeds V_{UVLO} rising threshold.

5.10 Discharge Mode (Soft-Stop)

When a transition to shutdown mode occurs or the V_{IN} UVLO is set, the discharge function is to ensure a defined down-ramp of the output voltage and keep the output voltage close to 0V. The output voltage is discharged to SGND through an internal 100 Ω switch.

5.11 100% Duty Cycle

The RAA210040 features a 100% duty cycle operation to minimize the switching losses. When the input voltage drops to a level that the RAA210040 can no longer maintain regulation at the output, the module completely turns on the P-channel MOSFET. This is particularly useful in battery-powered applications to make full use of the battery voltage and maximize the operation time.

5.12 Thermal Shutdown

The RAA210040 has built-in thermal protection. When the internal temperature reaches +150°C, the module shuts down. Both MOSFETs are turned off and PG goes low. As the temperature drops to +125°C, the RAA210040 resumes operation by stepping through the soft start-up.

6. Application Information

6.1 Output Voltage Programming

The output voltage of the module is programmed by an external resistor divider (R_1 and R_2 in [Figure 3](#)). R_2 combined with the internal 100kΩ 0.5% resistor connected from FB to VSENSE forms a resistor divider that sets the output voltage. The output voltage is governed by [Equation 2](#).

$$(EQ. 2) \quad V_{OUT} = V_{REF} \cdot \frac{R_2 + R_1}{R_2}$$

Note: The output voltage accuracy is also dependent on the resistor accuracy of R_1 and R_2 . You need to select high accuracy resistors to achieve the overall output accuracy.

Table 3. Output Voltage Resistor Settings

V_{OUT} (V)	R_1 (kΩ)	R_2 (kΩ)
0.6	100	open
0.8	100	301
0.9	100	200
1.0	100	150
1.2	100	100
1.5	100	66.5
1.8	100	49.9
2.5	100	31.6
3.3	100	22.1

6.2 Switching Frequency Selection

With varieties of input and output voltage combinations, you must choose wisely on which frequency to operate at according to the specific applications. The selection of switching frequency for each V_{IN} and V_{OUT} combination needs to take into account a few trade-offs. Generally, lower switching frequency leads to higher efficiency at the cost of higher output voltage ripple. Do not decrease the switching frequency too low because of the negative current protection limit. Do not increase the switching frequency too high because of the minimum on-time limit, especially at low V_{OUT} . Moreover, when the output voltage is relatively high, low switching frequency results in more sub-harmonic oscillation. Therefore, operating frequency needs to be kept relatively high under high V_{OUT} conditions. However, to ensure better thermal performance, the switching frequency cannot be increased too much.

6.3 Input Capacitor Selection

The selection of the input filter capacitor is based on how much ripple the supply can tolerate on the DC input line. The larger the capacitor, the less ripple expected; however, you need to consider the higher surge current during power-up. The RAA210040 provides a soft start-up function that controls and limits the current surge. The total capacitance of the input capacitor is calculated using [Equation 3](#):

$$(EQ. 3) \quad C_{IN(MIN)} = \frac{I_O \cdot D(1-D)}{V_{P-P} \cdot f_{SW}}$$

where:

- $C_{IN(MIN)}$ is the minimum required input capacitance (μF)
- I_O is the output current (A)
- D is the duty cycle
- V_{P-P} is the allowable peak-to-peak input voltage (V)
- f_{SW} is the switching frequency (Hz)

Renesas recommends placing a low Equivalent Series Resistance (ESR) ceramic capacitor as close as possible to the module input. This input capacitor reduces voltage ringing created by the switching current across parasitic circuit elements. It also reduces the input noise seen by the module. Moreover, you need to consider the estimated RMS ripple current in choosing ceramic capacitors. The RMS ripple current is calculated using [Equation 4](#).

$$(EQ. 4) \quad I_{IN(RMS)} = \frac{I_O \sqrt{D(1-D)}}{\eta}$$

Each 22 μF X7R ceramic capacitor is typically good for 2A to 3A of RMS ripple current. See the capacitor datasheet for the RMS current ratings.

Based on the previous considerations, a minimum total input capacitance of 2x22 μF is required for the RAA210040. Add additional capacitance if possible. Use X7R ceramic capacitors. The placement of the input ceramic capacitors should be as close as possible to the module input. See [PCB Layout Pattern Design](#) for more information. A bulk input capacitance may also be needed if the input source does not have enough output capacitance. The typical value of a bulk input capacitor is 47 μF . In such conditions, this bulk input capacitance can supply the current during output load transient conditions.

6.4 Output Capacitor Selection

Ceramic capacitors with low ESR are typically used as the output capacitors for the RAA210040. To keep the low resistance up to high frequencies and to get narrow capacitance variations with the temperatures, Renesas recommends using dielectric X7R or equivalent. See [Table 2](#) for recommended output capacitor values. Bulk output capacitors that have adequately low ESR, such as low ESR polymer capacitors or a low ESR tantalum capacitor, can also be used in combination with the ceramic capacitors, depending on the output voltage ripple and transient requirements.

7. Layout Guidelines

Careful attention to layout requirements is necessary for successful implementation of the RAA210040 power module. The RAA210040 operates at high switching frequencies. Therefore, an optimized layout can minimize the impacts of high di/dt and dv/dt. Conversely, a poor layout can lead to poor regulation (both line and load), degraded efficiency, increased EMI radiation, noise sensitivity, and thermal stress.

7.1 Layout Considerations

The following are the layout considerations.

- Place the input ceramic capacitors as close as possible to the module input. These ceramic capacitors minimize the high frequency noise by reducing the parasitic inductance of the power loop. Proper placement of these capacitors not only leads to less PHASE node spikes and ringing, but also minimizes the switching noise coupled to the module. Renesas recommends using dielectric X7R or equivalent with a minimum total capacitance of 44 μF at the module input. A layout example is shown in [Figure 36](#) and [Figure 37](#).

- Use large copper planes to minimize conduction loss and thermal stress for VIN, VOUT, and PGND. Use multiple vias to connect the power planes in different layers.
- Use a separate SGND plane for components that are connected to SGND. Connect SGND and PGND at a single point on the top layer as shown in [Figure 38](#).
- Use a remote-sensing trace to connect to the point-of-load and achieve tight output voltage regulation. Route the remote-sensing trace underneath the PGND layer and avoid routing it near noisy planes. Place a 2Ω resistor close to the output voltage resistor divider and FB pin to damp the noise on the trace.

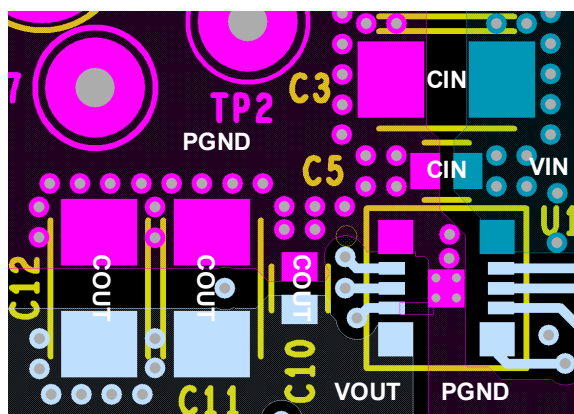


Figure 36. Layout Example - Top Layer

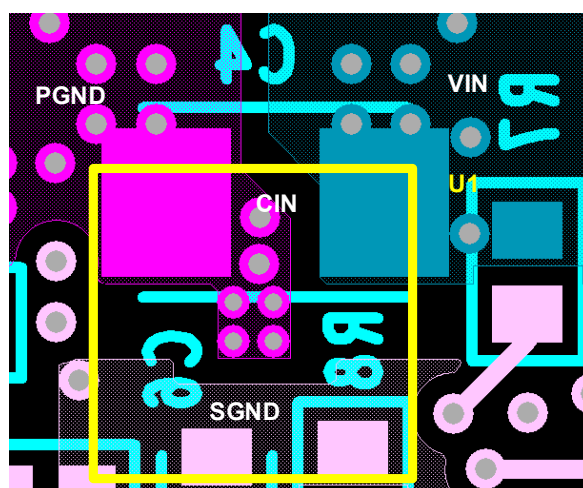


Figure 37. Layout Example - Bottom Layer

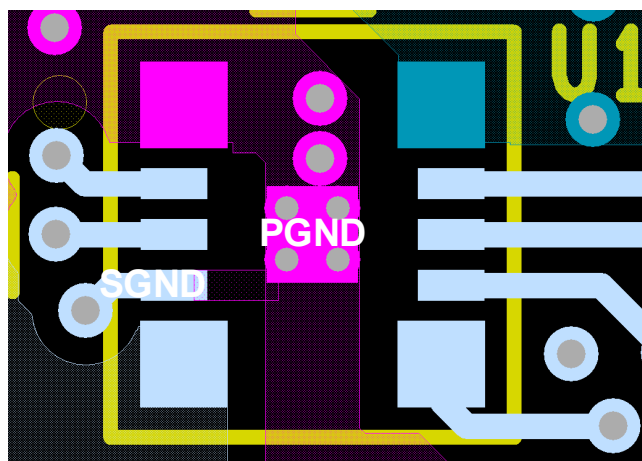


Figure 38. Layout Example - SGND is Connected to PGND at Single Point

7.2 Thermal Considerations

Experimental power loss curves, along with θ_{JA} from thermal modeling analysis, can evaluate the thermal consideration for the module. The derating curves are derived from the maximum power allowed while maintaining the temperature below the maximum junction temperature of +120°C. In applications in which the system parameters and layout are different from the evaluation board, the customer can adjust the margin of safety. All derating curves are obtained from tests on a 4-layer thermal test board 4.5x3 inches in size with 2oz copper on both top and bottom layers and 1oz copper on internal layers. See [TB379](#) for more details. In the actual application, other heat sources and design margins should be considered.

8. Package Description

The RAA210040 is integrated into a 10 Lead Dual Flat Embedded Laminate Package with exposed copper thermal pads. This package has such advantages as good thermal and electrical conductivity, low weight, and small size. The package is applicable for surface mounting technology and is becoming more common in the industry. The embedded laminate substrate and inductor are overmolded with a polymer mold compound to protect these devices.

The package outline, typical PCB layout pattern, and typical stencil pattern design are shown in the [Package Outline Drawing](#).

[R70TB0004EU](#): *PCB Design and Assembly Recommendations for Renesas Power Modules* shows the typical reflow profile parameters. These guidelines are general design rules. You can modify parameters according to your specific application.

8.1 PCB Layout Pattern Design

The bottom of RAA210040 is an embedded laminate substrate, which is attached to the PCB by surface mounting. The PCB layout pattern is in the Y10.3x3 [Package Outline Drawing](#). The PCB layout pattern is essentially 1:1 with the package exposed pad and the I/O termination dimensions, except that the PCB lands are slightly longer than the dual flat embedded laminate package terminations by about 0.3mm. This extension allows for solder filleting around the package periphery and ensures a more complete and inspectable solder joint. The thermal lands on the PCB layout should match 1:1 with the package exposed die pads.

8.2 Thermal Vias

Place a grid of 1.0mm to 1.2mm pitched thermal vias, which drops down and connects to buried copper planes under the thermal land. The vias should be about 0.3mm to 0.33mm in diameter, with the barrel plated to about 2.0 ounce copper. Although adding more vias (by decreasing pitch) improves thermal performance, it also diminishes results as more vias are added. Use only as many vias as needed for the thermal land size and as your board design rules allow.

8.3 Stencil Pattern Design

Reflowed solder joints on the perimeter I/O lands should have about a 50µm to 75µm (2 mil to 3 mil) standoff height. The solder paste stencil design is the first step in developing optimized, reliable solder joints. The stencil aperture size to land size ratio should typically be 1:1. Reduce the aperture width slightly to help prevent solder bridging between adjacent I/O lands.

Renesas recommends using an array of smaller apertures instead of one large aperture to reduce the solder paste volume on larger thermal lands. The stencil printing area should cover 50% to 80% of the PCB layout pattern. Consider the symmetry of the whole stencil pattern when designing the pads.

Renesas recommends using a laser-cut, stainless-steel stencil with electropolished trapezoidal walls. Electropolishing smooths the aperture walls, resulting in reduced surface friction and better paste release, which reduces voids. Using a Trapezoidal Section Aperture (TSA) also promotes paste release and forms a brick-like paste deposit, which assists in firm component placement.

8.4 Reflow Parameters

Renesas recommends using a No Clean Type 3 solder paste, per ANSI/J-STD-005 because of the low mount height of the package. Nitrogen purge is also recommended during reflow. A system board reflow profile depends on the thermal mass of the entire populated board, therefore, it is not practical to define a specific soldering profile just for the package. The profile given in [R70TB0004EU](#) is provided as a guideline to customize for varying manufacturing practices and applications.

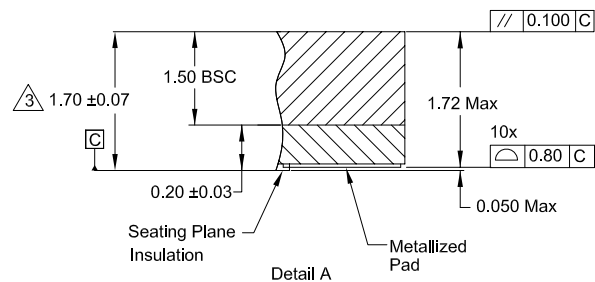
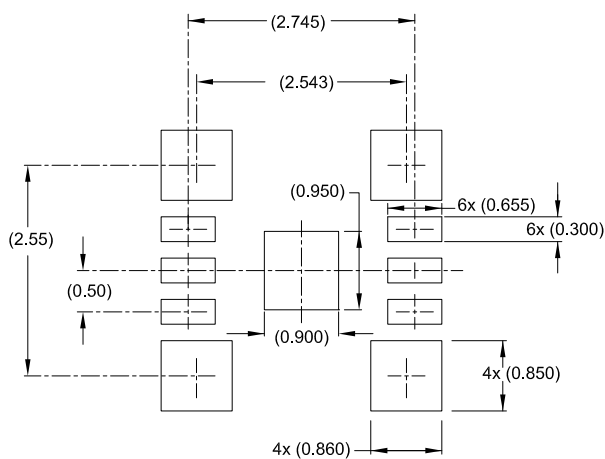
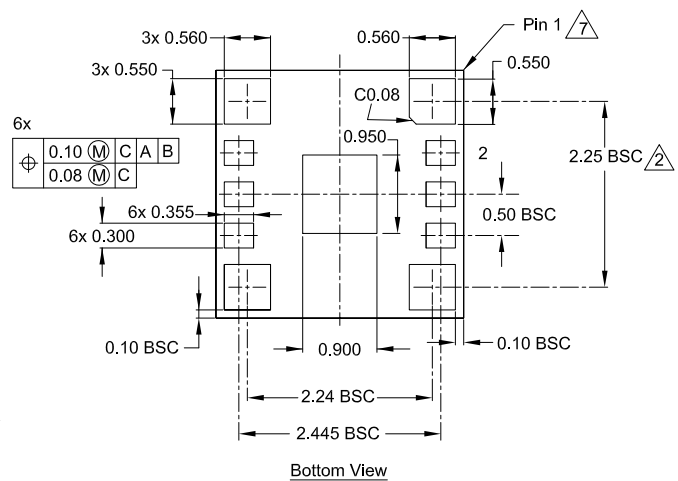
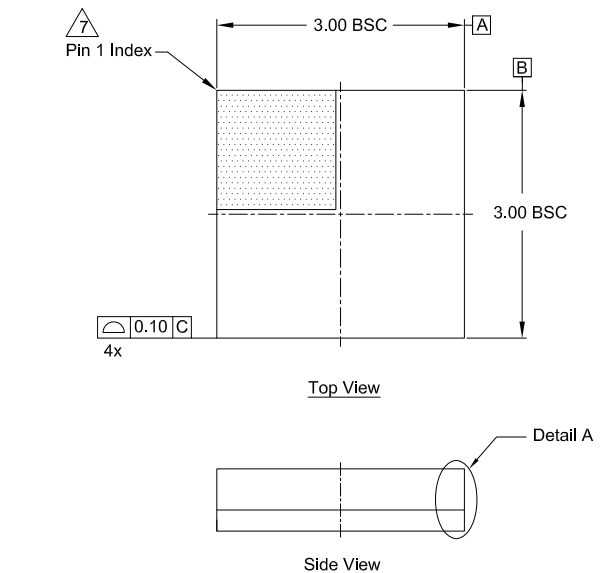
9. Package Outline Drawing

For the most recent package outline drawing, see [Y10.3x3](#).

Y10.3x3

10 Lead Dual Flat Embedded Laminate Package

Rev 1, 9/20



Notes :

- All dimensions are in mm.
Dimensions in () for reference only.
- Represents the basic terminal pitch.
Specifies the true geometric position of the terminal axis.
- Dimension includes package warpage.
- Exposed metallized pads are Cu pads with surface finish protection.
- Package dimensions refer to JEDEC MO-208 rev.c.
- Dimensioning and tolerancing conform to ASME Y14.5m-1994.
Unless otherwise specified, tolerance: Decimal ±0.05
- The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier can be either a mold or mark feature.

10. Ordering Information

Part Number ^{[1][2]}	Part Marking	Package Description ^[3] (RoHS Compliant)	Pkg. Dwg. #	Carrier Type ^[4]	Junction Temperature
RAA2100404GLG#HD0	0040	10 Lead Dual Flat Embedded Laminate Package	Y10.3x3	Reel, 3k	-40 to +125
RAA2100404GLG#MD0				Reel, 1k	
RTKA210040DR0000BU	Demonstration Board				

1. These plastic packaged products are RoHS compliant by EU exemption 7C-I and employ special Pb-free material sets; molding compounds/die attach materials and NiPdAu plate - e4 termination finish which is compatible with both SnPb and Pb-free soldering operations. RoHS compliant products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J-STD-020.
2. For Moisture Sensitivity Level (MSL), see the [RAA210040](#) device page. For information about MSL, see [TB363](#).
3. For the Pb-Free Reflow Profile, refer to [R70TB0004EU](#).
4. See [TB347](#) for details about reel specifications.

11. Revision History

Rev.	Date	Description
1.01	Jun 15, 2023	Changed all references for TB493 to R70TB0004EU. Updated the package description throughout document.
1.00	Apr 13, 2021	Initial release

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